STI6N95K5



N-channel 950 V, 1 Ω typ., 9 A MDmesh™ K5 Power MOSFET in an I²PAK package

Datasheet - production data

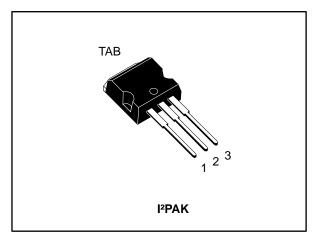
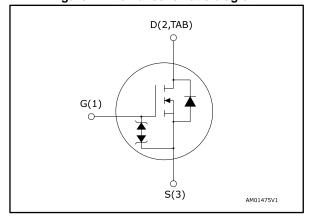


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD	Ртот
STI6N95K5	950 V	1.25 Ω	9 A	90 W

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STI6N95K5	6N95K5	I²PAK	Tube

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STI6N95K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	±30	V
I _D	Drain current (continuous) at T _C = 25 °C	9	Α
ΙD	Drain current (continuous) at T _C = 100 °C	6	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	36	Α
P _{TOT}	Total dissipation at T _C = 25 °C	90	
dv/dt (2)	Peak diode recovery voltage slope	4.5	\
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns
Tj	Operating junction temperature range	- 55 to 150	°C
T _{stg}	Storage temperature range	- 55 10 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	1.39	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	3	А
Eas	Single pulse avalanche energy (starting T _j = 25 °C, I _D = I _{AR} , V _{DD} = 50 V)	90	mJ

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \leq 9$ A, di/dt ≤ 100 A/µs; V_{DS} peak < V(BR)DSS

 $^{^{(3)}}V_{DS} \le 760 \text{ V}$

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	950			V
		$V_{GS} = 0 \text{ V}, V_{DS} = 950 \text{ V}$			1	μΑ
I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 950 \text{ V}$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μΑ	
Igss	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	V _G S = 10 V, I _D = 3 A		1	1.25	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	450	-	pF
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	ı	30	-	pF
Crss	Reverse transfer capacitance	V63 - 0 V	-	1.6	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 760 V,	-	45	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{GS} = 0 V	1	19	-	pF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	ı	7	-	Ω
Qg	Total gate charge	$V_{DD} = 760 \text{ V}, I_D = 6 \text{ A}$	-	13	-	nC
Qgs	Gate-source charge	V _{GS} = 0 to 10 V	-	3	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	7	-	nC

Notes:

⁽¹⁾ Defined by design, not subject to production test.

 $^{^{(1)}}$ C_{o(tr)} is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

 $^{^{(2)}}$ $C_{\text{O(er)}}$ is a constant capacitance value that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 80% V_{DSS} .

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 475 V, I _D = 3 A,	-	12	-	ns
tr	Rise time	$R_G = 4.7 \Omega$	ı	12	-	ns
t _{d(off)}	Turn-off delay time	V _{GS} = 10 V (see Figure 14: "Test circuit for	-	33	-	ns
t _f	Fall time	resistive load switching times" and Figure 19: "Switching time waveform")	-	21	-	ns

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		ı		9	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		36	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 6 A, V _{GS} = 0 V	-		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 6 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	372		ns
Qrr	Reverrse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for	-	4		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	ı	22		Α
t _{rr}	Reverse recovery time	$I_{SD} = 6 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	522		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 \text{ °C}$ (see Figure 16: "Test circuit for	-	5		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	1	20		А

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_{D} = 0 \text{ A}$	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

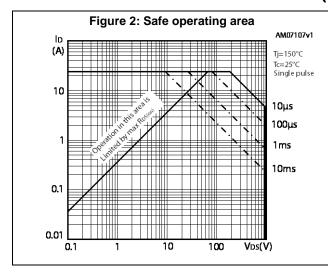
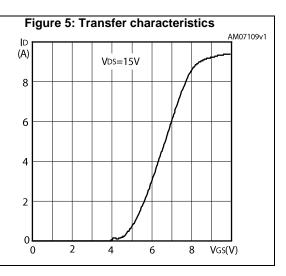
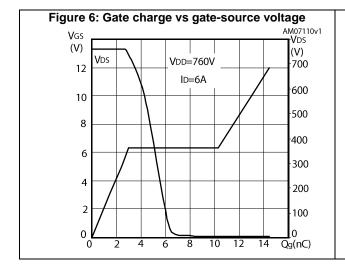
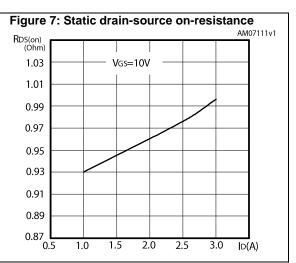


Figure 3: Thermal impedance $K \\ \overline{\delta} = 0.5$ $\overline{\delta} = 0.5$ $\overline{\delta} = 0.1$ $\overline{\delta} = 0.1$ $\overline{\delta} = 0.01$ $\overline{\delta} = 0.05$ $\overline{\delta} = 0.02$ $\overline{\delta} = 0.01$ $\overline{\delta} = 0.01$

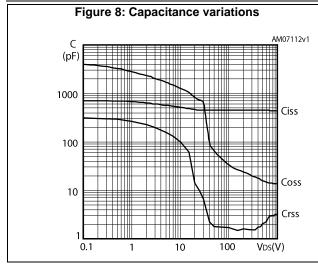
Figure 4: Output characteristics ID(A) VGS=10V 12 10 8 7V 6 4 6V 2 5V 0 15 20 25 VDS(V)

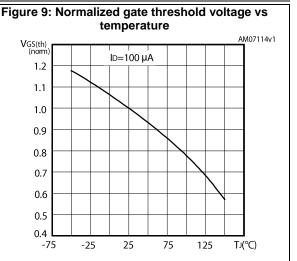


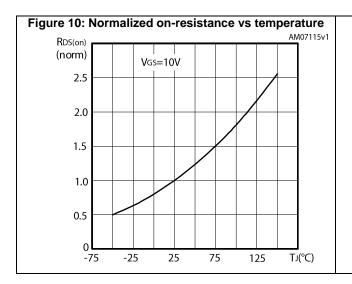


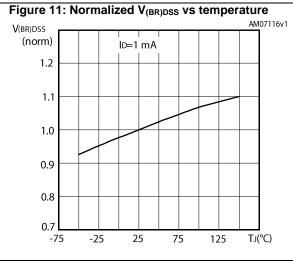


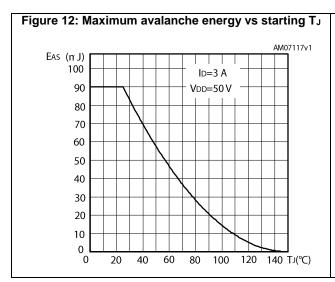
STI6N95K5 Electrical characteristics

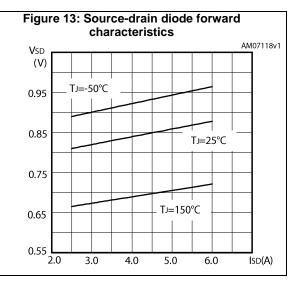








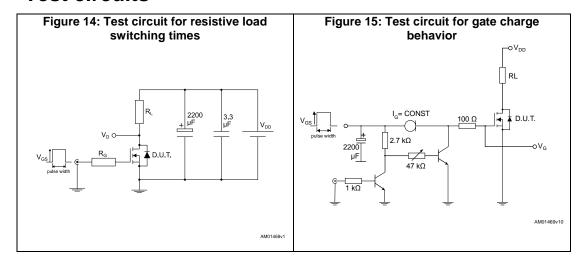


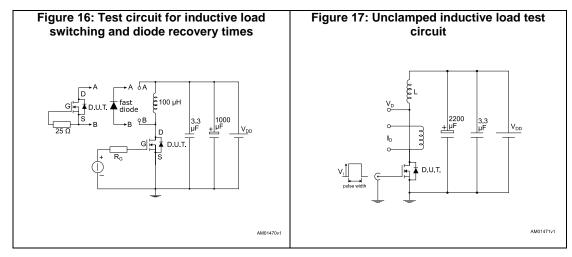


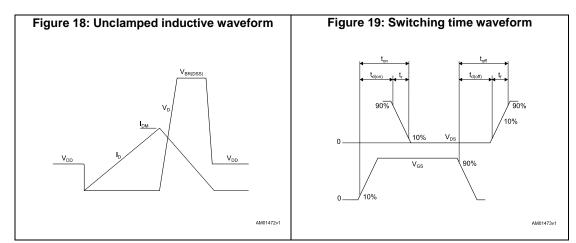


Test circuits STI6N95K5

3 Test circuits







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STI6N95K5 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 I²PAK package information

 $\begin{array}{c} L2 \\ D \\ D \\ D \\ D \\ C \end{array}$

Figure 20: I²PAK package outline

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Table 10: I²PAK package mechanical data

Dim	mm			
Dim.	Min.	Тур.	Max.	
А	4.40	-	4.60	
A1	2.40	-	2.72	
b	0.61	-	0.88	
b1	1.14	-	1.70	
С	0.49	-	0.70	
c2	1.23	-	1.32	
D	8.95	-	9.35	
е	2.40	-	2.70	
e1	4.95	-	5.15	
Е	10	-	10.40	
L	13	-	14	
L1	3.50	-	3.93	
L2	1.27	-	1.40	

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STI6N95K5 Revision history

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
03-May-2017	1	First release.

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